Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/909,176	FUCCELLO ET AL.	
Examiner	Art Unit	
Tri H. Phan	2661	

SEARCHED				
Class	Subclass	Date	Examiner	
370	310,315, 328,338, 400-401	8/8/2005	TP	
370	395.2+	8/8/2005	TP	
370	395.52	8/8/2005	TP	
709	217-219	8/8/2005	TP	
709	223-229	8/8/2005	TP	
709	249	8/8/2005		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	l				

SEARCH N (INCLUDING SEARC		')
	DATE	EXMR
EAST, IEEE, Internet search	8/8/2005	TP
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